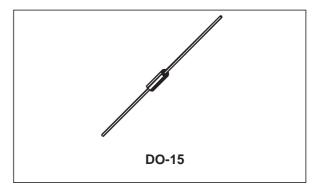


# **TPA SERIES**

#### **FEATURES**

- BIDIRECTIONAL CROWBAR PROTECTION.
- VOLTAGE RANGE: FROM 62 V TO 270 V.
- HOLDING CURRENT : I<sub>H</sub> = 150mA min.
- REPETITIVE PEAK PULSE CURRENT: IPP = 50 A, 10/1000 μs.

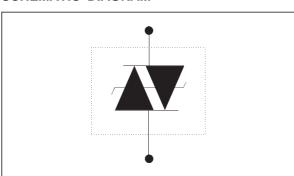


#### **DESCRIPTION**

The TPA series are TRISIL devices especially designed for protecting sensitive telecommunication equipment against lightning and transient voltages induced by AC power lines. They are available in the DO-15 axial package.

TRISIL devices provide bidirectional protection by crowbar action. Their characteristic response to transient overvoltages makes them particularly suited to protect voltage sensitive telecommunication equipment.

#### **SCHEMATIC DIAGRAM**



COMPLIES WITH THE FOLLOWING STANDARDS:	Peak Surge Voltage (V)	Voltage Waveform (μs)	Current Waveform (μs)	Admissible lpp (A)	Necessary Resistor (Ω)
(CCITT) ITU-K20	1000	10/700	5/310	25	-
(CCITT) ITU-K17	1500	10/700	5/310	38	-
VDE0433	2000	10/700	5/310	50	-
VDE0878	2000	1.2/50	1/20	50	-
IEC-1000-4-5	level 3 level 4	10/700 1.2/50	5/310 8/20	50 100	-
FCC Part 68, lightning surge type A	1500 800	10/160 10/560	10/160 10/560	75 55	12.5 6.5
FCC Part 68, lightning surge type B	1000	9/720	5/320	25	-
BELLCORE TR-NWT-001089 First level	2500 1000	2/10 10/1000	2/10 10/1000	150 50	11.5 10
BELLCORE TR-NWT-001089 Second level	5000	2/10	2/10	150	11.5
CNET I31-24	1000	0.5/700	0.8/310	25	-

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## **TPA SERIES**

# **ABSOLUTE MAXIMUM RATINGS** $(T_{amb} = 25^{\circ}C)$

Symbol	Parameter	Value	Unit	
Р	Power dissipation on infinite heatsink	T <sub>amb</sub> = 50 °C	1.7	W
Ірр	Peak pulse current	10/1000 μs 8/20 μs	50 100	А
I <sub>TSM</sub>	Non repetitive surge peak on-state current	tp = 20 ms	30	Α
l <sup>2</sup> t	I <sup>2</sup> t value for fusing	tp = 20 ms	9	A <sup>2</sup> s
dV/dt	Critical rate of rise of off-state voltage	V <sub>RM</sub>	5	kV/μs
T <sub>stg</sub> T <sub>j</sub>	Storage temperature range Maximum junction temperature		- 55 to + 150 150	°C °C

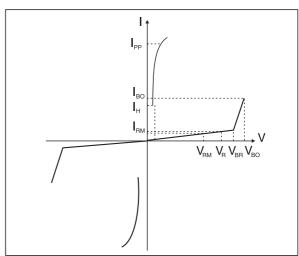
## THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
R <sub>th</sub> (j-l)	Junction to leads (L <sub>lead</sub> = 10mm)	60	°C/W
R <sub>th</sub> (j-a)	Junction to ambient on printed circuit (L <sub>lead</sub> = 10 mm)	100	°C/W

## **ELECTRICAL CHARACTERISTICS**

 $(T_{amb} = 25^{\circ}C)$ 

Symbol	Parameter				
$V_{RM}$	Stand-off voltage				
I <sub>RM</sub>	Leakage current at stand-off voltage				
V <sub>R</sub>	Continuous Reverse voltage				
$V_{BR}$	Breakdown voltage				
V <sub>BO</sub>	Breakover voltage				
I <sub>H</sub>	Holding current				
I <sub>BO</sub>	Breakover current				
I <sub>PP</sub>	Peak pulse current				
С	Capacitance				

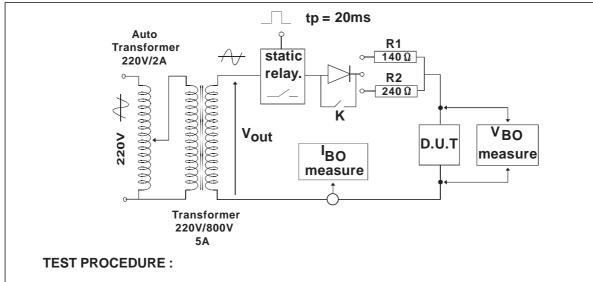


Туре	I <sub>RM</sub> @ max.	V <sub>RM</sub>	I <sub>R</sub> @ max. note 1	V <sub>R</sub>	V <sub>BO</sub> ( max. note 2	@ I <sub>BO</sub>	I <sub>H</sub> min. note 3	C max. note 4
	μ <b>Α</b>	V	μ <b>Α</b>	V	V	mA	mA	pF
TPA62	2	56	50	62	82	800	150	150
TPA68	2	61	50	68	90	800	150	150
TPA100	2	90	50	100	133	800	150	100
TPA120	2	108	50	120	160	800	150	100
TPA130	2	117	50	130	173	800	150	100
TPA180	2	162	50	180	240	800	150	100
TPA200	2	180	50	200	267	800	150	100
TPA220	2	198	50	220	293	800	150	100
TPA240	2	216	50	240	320	800	150	100
TPA270	2	243	50	270	360	800	150	100

 $\begin{array}{ll} \textbf{Note 1:} & I_R \text{ measured at } V_R \text{ guarantee } V_{BRmin} \ \big| \ V_R \\ \textbf{Note 3:} & See \text{ test circuit 2.} \end{array}$ 

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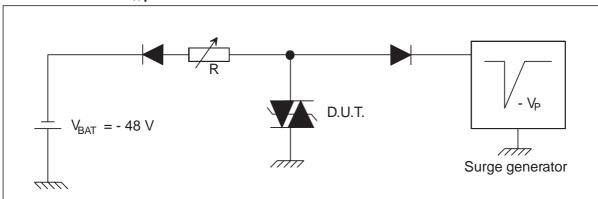
## TEST CIRCUIT 1 FOR I<sub>BO</sub> and V<sub>BO</sub> parameters :



- Pulse Test duration (tp = 20ms):
  - For Bidirectional devices = Switch K is closed
  - For Unidirectional devices = Switch K is open.
- Vout Selection

  - Device with  $V_{BO}$  < 200 Volt Vout = 250 V<sub>RMS</sub>, R<sub>1</sub> = 140  $\Omega$ . Device with  $V_{BO}$  | 200 Volt
  - - $V_{OUT} = 480 \text{ V}_{RMS}$ ,  $R_2 = 240 \Omega$ .

## TEST CIRCUIT 2 for I<sub>H</sub> parameter.

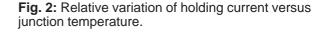


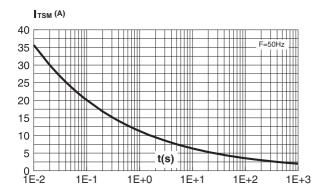
This is a GO-NOGO Test which allows to confirm the holding current (I<sub>H</sub>) level in a functional test circuit.

## **TEST PROCEDURE:**

- 1) Adjust the current level at the I<sub>H</sub> value by short circuiting the AK of the D.U.T.
  - 2) Fire the D.U.T with a surge Current : Ipp = 10A,  $10/1000 \,\mu s$ .
  - 3) The D.U.T will come back off-state within 50 ms max.

**Fig. 1:** Non repetitive surge peak on-state current versus overload duration (Tj initial=25°C).



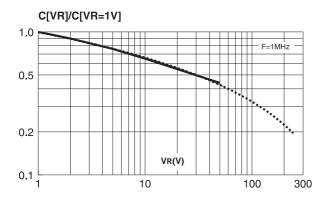


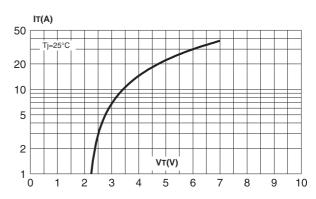
IH[Tj] / IH[Tj=25°C]

2.0
1.8
1.6
1.4
1.2
1.0
0.8
0.6
0.4
0.2
-40 -20 0 20 40 60 80 100

**Fig. 3:** Relative variation of junction capacitance versus reverse applied voltage (typical values). **Note:** For  $V_{RM}$  upper than 56V, the curve is extrapolated (dotted line).

**Fig. 4:** On-state current versus on-state voltage (typical values).





**Fig. 5:** Transient thermal impedance junction to ambient versus pulse duration (for FR4 PC Board with  $T_{lead} = 10$  mm).

Zth(j-a)(°CW)

1E+2

1E+1

1E+0

1E-1

1E-3

1E-2

1E-1

1E+0

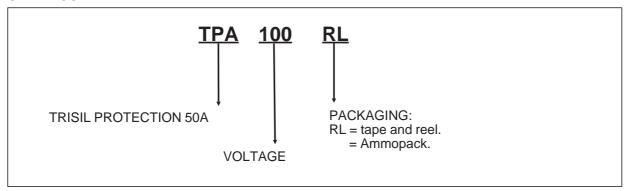
1E+1

1E+2

5E+2

4/5

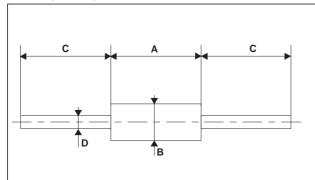
#### **ORDER CODE**



MARKING: Logo, Date Code, Part Number.

#### **PACKAGE MECHANICAL DATA**

DO-15 (Plastic)



REF.	DIMENSIONS						
	Millim	neters	Inc	hes			
	Min. Max.		Min.	Max.			
Α	6.05	6.75	0.238	0.266			
В	2.95	3.53	0.116	0.139			
С	26	31	1.024	1.220			
D	0.71	0.88	0.028	0.035			

Weight: 0.4 g

Packaging: Standard packaging is in tape and reel.

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